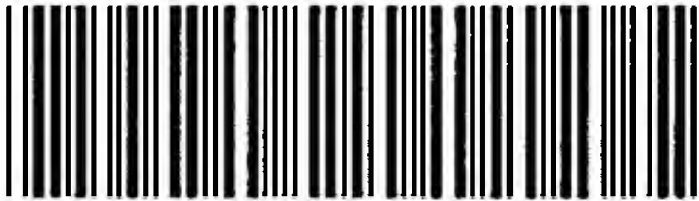


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,653	YU ET AL.	
	Examiner	Art Unit	
	Jason M. Han	2875	

SEARCHED			
Class	Subclass	Date	Examiner
362	29-30	2/17/2006	JMH
362	97	2/17/2006	JMH
349	61-69	2/17/2006	JMH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	2/17/2006	JMH